ON Semiconductor®

# FDN5618P

## 60V P-Channel Logic Level PowerTrench® MOSFET

### General Description

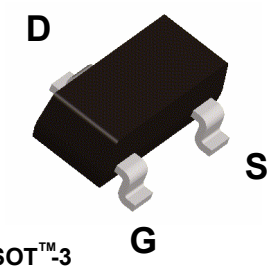
This 60V P-Channel MOSFET uses ON Semiconductor's high voltage PowerTrench process. It has been optimized for power management applications.

### Applications

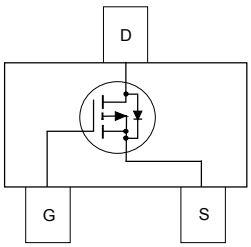
- DC-DC converters
- Load switch
- Power management

### Features

- –1.25 A, –60 V. $R_{DS(ON)}$ = 0.170 Ω @ $V_{GS}$ = –10 V
  $R_{DS(ON)}$ = 0.230 Ω @ $V_{GS}$ = –4.5 V
- Fast switching speed
- High performance trench technology for extremely low $R_{DS(ON)}$




SuperSOT™-3




## Absolute Maximum Ratings $T_A$=25°C unless otherwise noted

| Symbol | Parameter | | Ratings | Units |
|---|---|---|---|---|
| $V_{DSS}$ | Drain-Source Voltage | | –60 | V |
| $V_{GSS}$ | Gate-Source Voltage | | ±20 | V |
| $I_D$ | Drain Current – Continuous | (Note 1a) | –1.25 | A |
| | – Pulsed | | –10 | |
| $P_D$ | Maximum Power Dissipation | (Note 1a) | 0.5 | W |
| | | (Note 1b) | 0.46 | |
| $T_J$, $T_{STG}$ | Operating and Storage Junction Temperature Range | | –55 to +150 | °C |

## Thermal Characteristics

| | | | | |
|---|---|---|---|---|
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | (Note 1a) | 250 | °C/W |
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case | (Note 1) | 75 | °C/W |

## Package Marking and Ordering Information

| Device Marking | Device | Reel Size | Tape width | Quantity |
|---|---|---|---|---|
| 618 | FDN5618P | 7'' | 8mm | 3000 units |

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Publication Order Number:
FDN5618P/D

## Electrical Characteristics

$T_A$ = 25°C unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|---|---|---|---|---|---|---|
| **Off Characteristics** | | | | | | |
| $BV_{DSS}$ | Drain–Source Breakdown Voltage | $V_{GS}$ = 0 V, $I_D$ = –250 μA | –60 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $I_D$ = –250 μA,Referenced to 25°C | | –58 | | mV/°C |
| $I_{DSS}$ | Zero Gate Voltage Drain Current | $V_{DS}$ = –48 V, $V_{GS}$ = 0 V | | | –1 | μA |
| $I_{GSSF}$ | Gate–Body Leakage, Forward | $V_{GS}$ = 20V, $V_{DS}$ = 0 V | | | 100 | nA |
| $I_{GSSR}$ | Gate–Body Leakage, Reverse | $V_{GS}$ = –20 V $V_{DS}$ = 0 V | | | –100 | nA |
| **On Characteristics** (Note 2) | | | | | | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS}$ = $V_{GS}$, $I_D$ = –250 μA | –1 | –1.6 | –3 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate Threshold Voltage Temperature Coefficient | $I_D$ = –250 μA,Referenced to 25°C | | 4 | | mV/°C |
| $R_{DS(on)}$ | Static Drain–Source On–Resistance | $V_{GS}$ = –10 V, $I_D$ = –1.25 A<br>$V_{GS}$ = –4.5 V, $I_D$ = –1.0 A<br>$V_{GS}$ = –10 V, $I_D$ = –3 A $T_J$=125°C | | 0.148<br>0.185<br>0.245 | 0.170<br>0.230<br>0.315 | Ω |
| $I_{D(on)}$ | On–State Drain Current | $V_{GS}$ = –10 V, $V_{DS}$ = –5 V | –5 | | | A |
| $g_{FS}$ | Forward Transconductance | $V_{DS}$ = –5 V, $I_D$ = –1.25 A | | 4.3 | | S |
| **Dynamic Characteristics** | | | | | | |
| $C_{iss}$ | Input Capacitance | $V_{DS}$ = –30 V, $V_{GS}$ = 0 V, f = 1.0 MHz | | 430 | | pF |
| $C_{oss}$ | Output Capacitance | | | 52 | | pF |
| $C_{rss}$ | Reverse Transfer Capacitance | | | 19 | | pF |
| **Switching Characteristics** (Note 2) | | | | | | |
| $t_{d(on)}$ | Turn–On Delay Time | $V_{DD}$ = –30 V, $I_D$ = –1 A, $V_{GS}$ = –10 V, $R_{GEN}$ = 6 Ω | | 6.5 | 13 | ns |
| $t_r$ | Turn–On Rise Time | | | 8 | 16 | ns |
| $t_{d(off)}$ | Turn–Off Delay Time | | | 16.5 | 30 | ns |
| $t_f$ | Turn–Off Fall Time | | | 4 | 8 | ns |
| $Q_g$ | Total Gate Charge | $V_{DS}$ = –30 V, $I_D$ = –1.25 A, $V_{GS}$ = –10 V | | 8.6 | 13.8 | nC |
| $Q_{gs}$ | Gate–Source Charge | | | 1.5 | | nC |
| $Q_{gd}$ | Gate–Drain Charge | | | 1.3 | | nC |
| **Drain–Source Diode Characteristics and Maximum Ratings** | | | | | | |
| $I_S$ | Maximum Continuous Drain–Source Diode Forward Current | | | | –0.42 | A |
| $V_{SD}$ | Drain–Source Diode Forward Voltage | $V_{GS}$ = 0 V, $I_S$ = –0.42 (Note 2) | | –0.7 | –1.2 | V |

**Notes:**

**1.** $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a) 250°C/W when mounted on a 0.02 in² pad of 2 oz. copper.



b) 270°C/W when mounted on a minimum pad.

Scale 1 : 1 on letter size paper

**2.** Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2.0

## Typical Characteristics

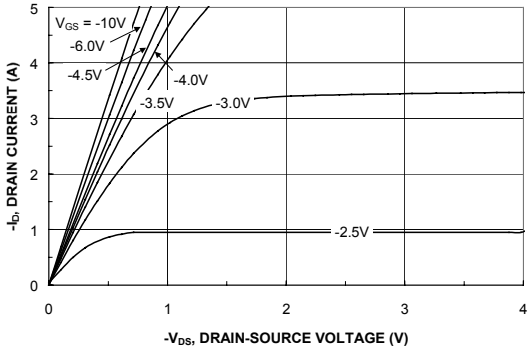



**Figure 1. On-Region Characteristics.**

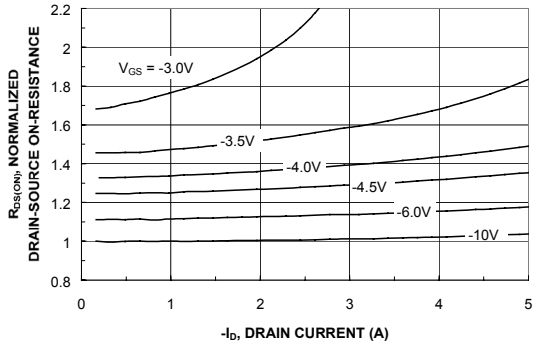



**Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.**

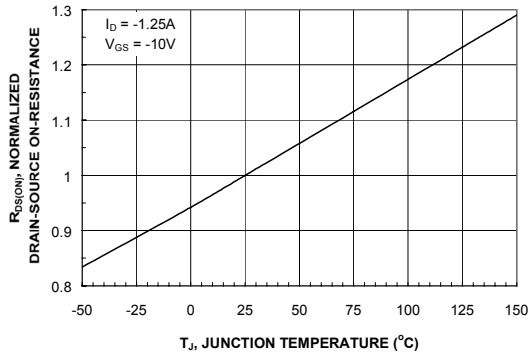



**Figure 3. On-Resistance Variation withTemperature.**

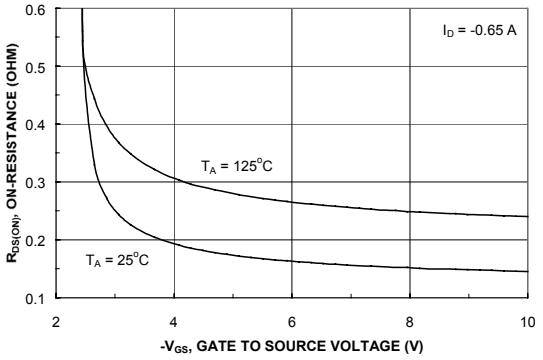



**Figure 4. On-Resistance Variation with Gate-to-Source Voltage.**

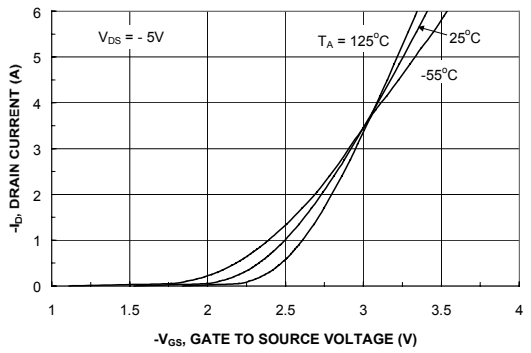



**Figure 5. Transfer Characteristics.**

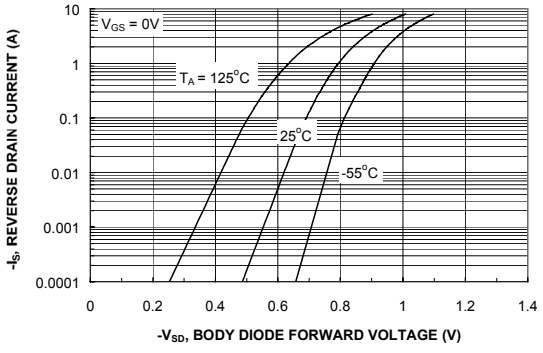



**Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.**

## Typical Characteristics

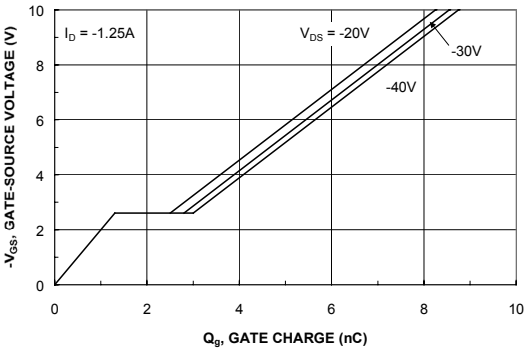



**Figure 7. Gate Charge Characteristics.**

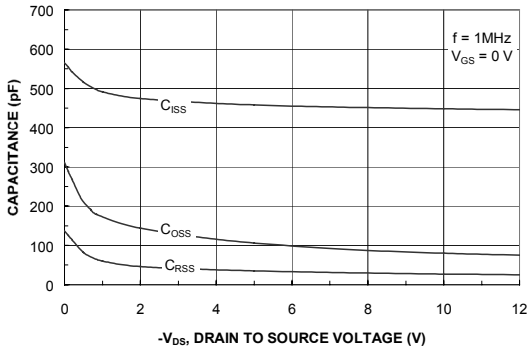



**Figure 8. Capacitance Characteristics.**

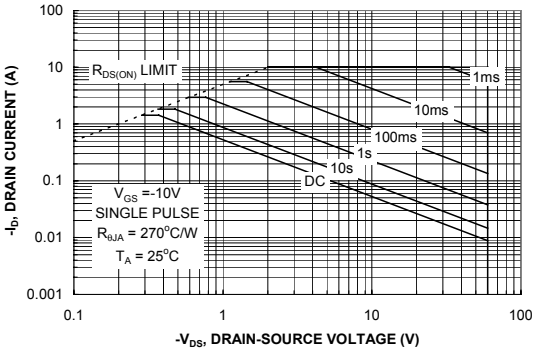



**Figure 9. Maximum Safe Operating Area.**

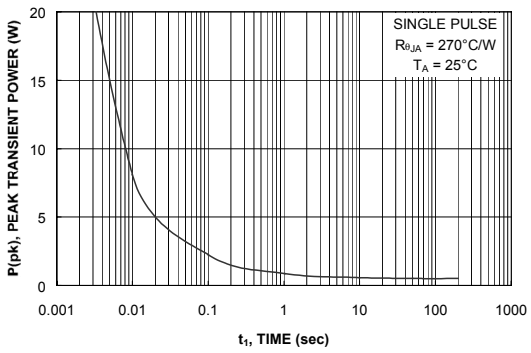



**Figure 10. Single Pulse Maximum Power Dissipation.**

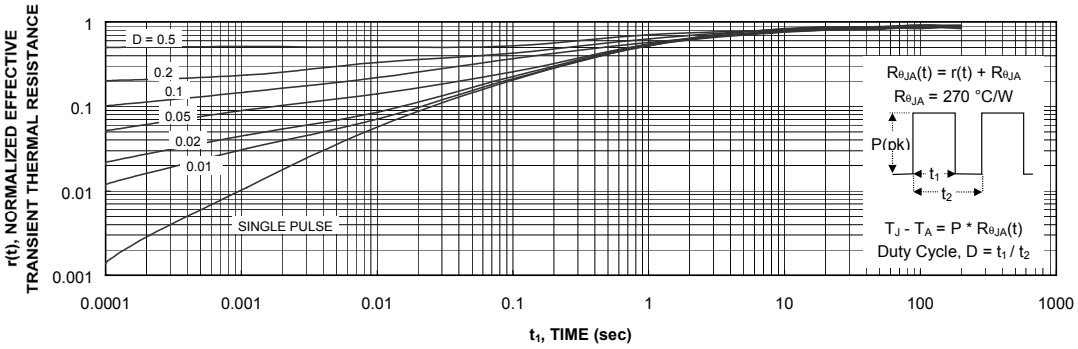



**Figure 11. Transient Thermal Response Curve.**

**Thermal characterization performed using the conditions described in Note 1b.**
**Transient thermal response will change depending on the circuit board design.**

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